Notice of References Cited Application/Control No. 09/964,910 Examiner Dah-Wei D. Yuan Applicant(s)/Patent Under Reexamination YAMAURA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0203139	10-2003	REN et al.	428/34.3
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FOREIGN PATENT DOCUMENTS

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